

Search Notes

Application/Control No.

10/782,858

Examiner

HABTE MERED

Applicant(s)/Patent under
Reexamination

KIM ET AL.

Art Unit

2616

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|-----------|----------|
| 370 | 475 | 4/17/2008 | HM |
| 370 | 354 | 4/17/2008 | HM |
| 370 | 338 | 4/17/2008 | HM |
| 370 | 349 | 4/17/2008 | HM |
| 370 | 395.53 | 4/17/2008 | HM |
| 370 | 329 | 4/17/2008 | HM |
| 709 | 245 | 4/17/2008 | HM |
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INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

| | DATE | EXMR |
|--|-----------|------|
| Searched EAST DB:USPAT, USPGPUB, JPO, and EPO | 4/17/2008 | HM |
| Searched Palm Inventor's DB | 4/17/2008 | HM |
| Searched IEEE | 4/17/2008 | HM |
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